



# Protection Devices

TVS (Transient Voltage Suppressor)

## ESD102-U1-02ELS

Uni-directional, 3.3 V, 0.4 pF, 0201, RoHS

ESD102-U1-02ELS

## Data Sheet

Revision 1.2, 2015-12-14  
Final

Power Management & Multimarket

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## 1 Product Overview

### 1.1 Features

- ESD / transient protection of high speed data lines according to:
  - IEC61000-4-2 (ESD):  $\pm 20$  kV (air / contact)
  - IEC61000-4-4 (EFT):  $\pm 2.5$  kV / 50 A (5/50 ns)
  - IEC61000-4-5 (surge):  $\pm 3$  A (8/20  $\mu$ s)
- Uni-directional working voltage:  $V_{RWM} = 3.3$  V
- Ultra low capacitance:  $C_L = 0.4$  pF (typical)
- Very low clamping voltage:  $V_{CL} = 8$  V (typical) at  $I_{PP} = 16$  A
- Low reverse current:  $I_R = 1$  nA (typical)
- Very low dynamic resistance:  $R_{DYN} = 0.19$   $\Omega$  (typical)
- Pb-free (RoHS compliant) and halogen free package, very small form factor  $0.62 \times 0.32 \times 0.31$  mm<sup>3</sup>



### 1.2 Application Examples

- USB 3.0, 10/100/1000 Ethernet, Firewire, DVI, HDMI, S-ATA, DisplayPort
- Mobile HDMI Link, MDDI, MIPI, SWP / NFC

### 1.3 Product Description

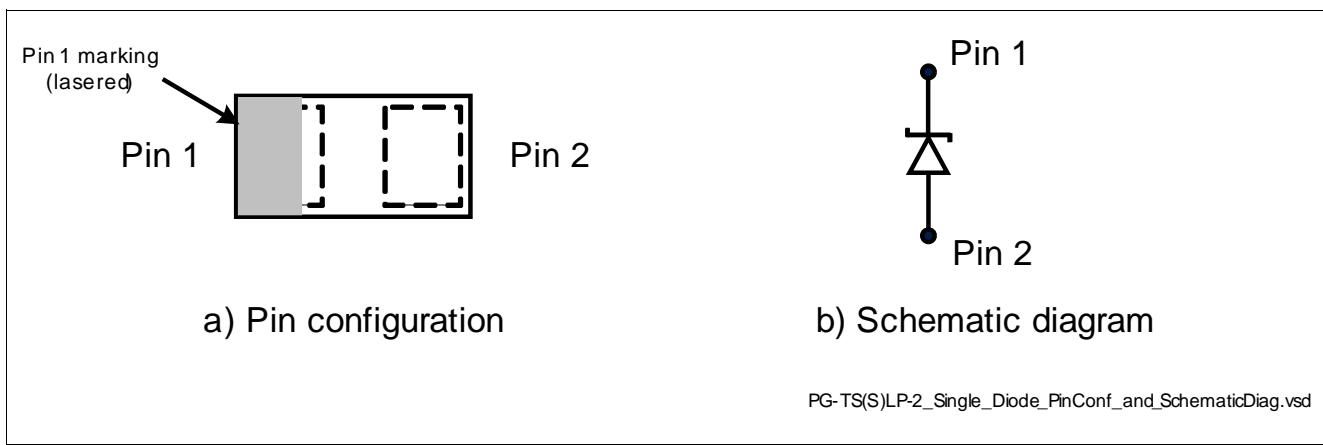


Figure 1 Pin Configuration and Schematic Diagram

Table 1 Part Information

Type	Package	Configuration	Marking code
ESD102-U1-02ELS	TSSLP-2-3	1 line, uni-directional	E

## Maximum Ratings

## 2 Maximum Ratings

**Table 2 Maximum Rating at  $T_A = 25^\circ\text{C}$ , unless otherwise specified**

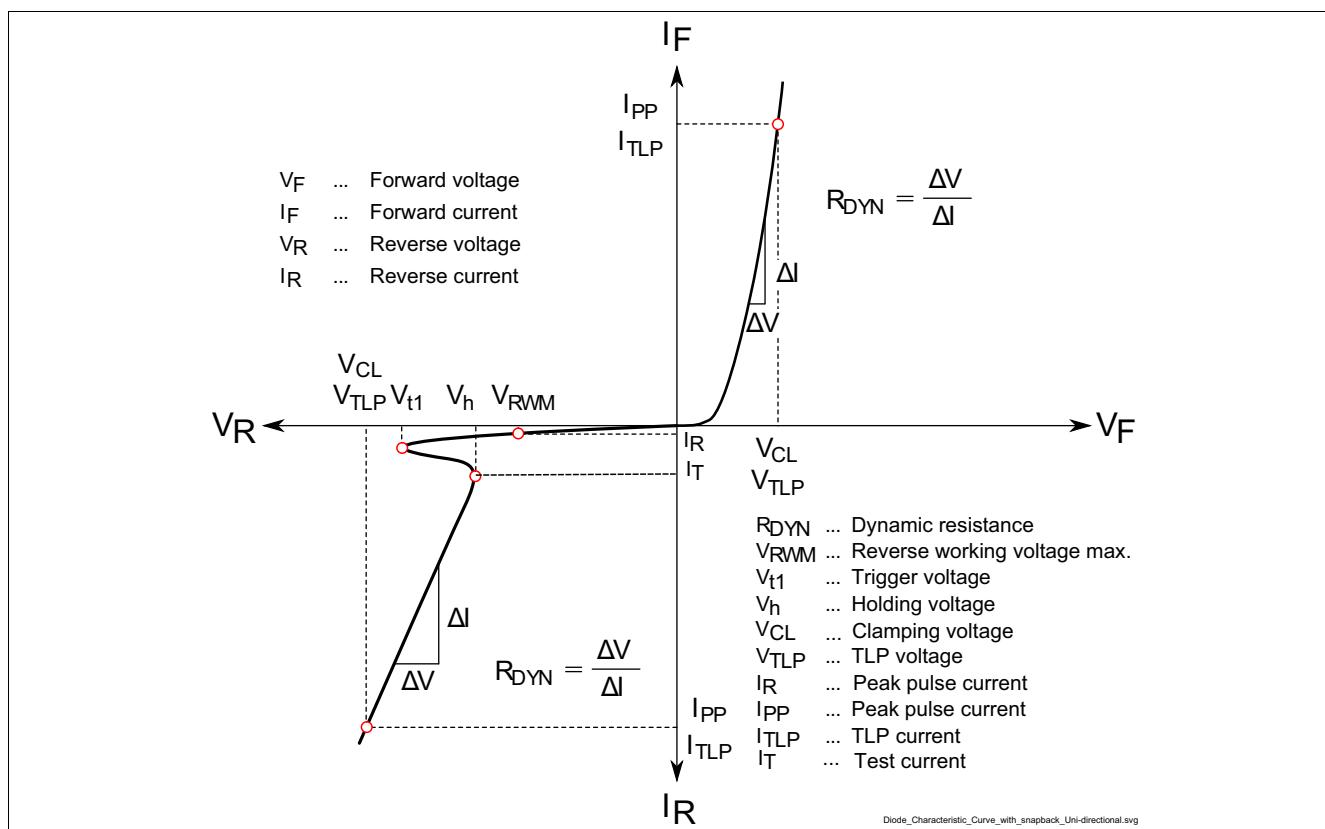
Parameter	Symbol	Values	Unit
ESD air discharge <sup>1)</sup>	$V_{\text{ESD}}$	$\pm 20$	kV
ESD contact discharge <sup>1)</sup>		$\pm 20$	
Peak pulse current <sup>2)</sup>	$I_{\text{PP}}$	$\pm 3$	A
Operating temperature	$T_{\text{OP}}$	-55 to 125	$^\circ\text{C}$
Storage temperature	$T_{\text{stg}}$	-65 to 150	$^\circ\text{C}$

1)  $V_{\text{ESD}}$  according to IEC61000-4-2

2) Stress pulse: 8/20 $\mu\text{s}$  current waveform according to IEC61000-4-5

**Attention: Stresses above the max. values listed here may cause permanent damage to the device.**  
**Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the integrated circuit.**

## 3 Electrical Characteristics at $T_A = 25^\circ\text{C}$ , unless otherwise specified



**Figure 2 Definitions of Electrical Characteristics**

Electrical Characteristics at  $T_A = 25^\circ\text{C}$ , unless otherwise specified

**Table 3 DC Characteristics** at  $T_A = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Reverse working voltage	$V_{RWM}$	—	—	3.3	V	Pin 1 to Pin 2
Trigger voltage	$V_{t1}$	—	6.2	—		
Holding voltage	$V_h$	3.35	4	4.4		Pin 1 to Pin 2, $I_R = 10 \text{ mA}$
Reverse current	$I_R$	—	1	50	nA	$V_R = 3.3 \text{ V}$ , from Pin 1 to Pin 2

**Table 4 AC Characteristics** at  $T_A = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Line capacitance	$C_L$	—	0.4	0.65	pF	$V_R = 0 \text{ V}, f = 1 \text{ MHz}$
		—	0.4	0.65	pF	$V_R = 0 \text{ V}, f = 1 \text{ GHz}$
Series inductance	$L_S$	—	0.2	—	nH	

**Table 5 ESD and Surge Characteristics** at  $T_A = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Clamping voltage <sup>1)</sup>	$V_{CL}$	—	8	—	V	$I_{TLP} = 16 \text{ A}, t_p = 100 \text{ ns}$ , from Pin 1 to Pin 2
		—	11	—		$I_{TLP} = 30 \text{ A}, t_p = 100 \text{ ns}$ , from Pin 1 to Pin 2
Forward clamping voltage <sup>1)</sup>	$V_{FC}$	—	6	—		$I_{TLP} = 16 \text{ A}, t_p = 100 \text{ ns}$ , from Pin 2 to Pin 1
		—	9	—		$I_{TLP} = 30 \text{ A}, t_p = 100 \text{ ns}$ , from Pin 2 to Pin 1
Dynamic resistance <sup>1)</sup>	$R_{DYN}$	—	0.19	—	$\Omega$	$t_p = 100 \text{ ns}$ , from Pin 1 to Pin 2
		—	0.23	—		$t_p = 100 \text{ ns}$ , from Pin 2 to Pin 1

1) Please refer to Application Note AN210[1]. TLP parameter:  $Z_0 = 50 \Omega$ ,  $t_p = 100 \text{ ns}$ ,  $t_r = 0.6 \text{ ns}$ .

Typical Characteristics at  $T_A=25^\circ\text{C}$ , unless otherwise specified

#### 4 Typical Characteristics at $T_A=25^\circ\text{C}$ , unless otherwise specified

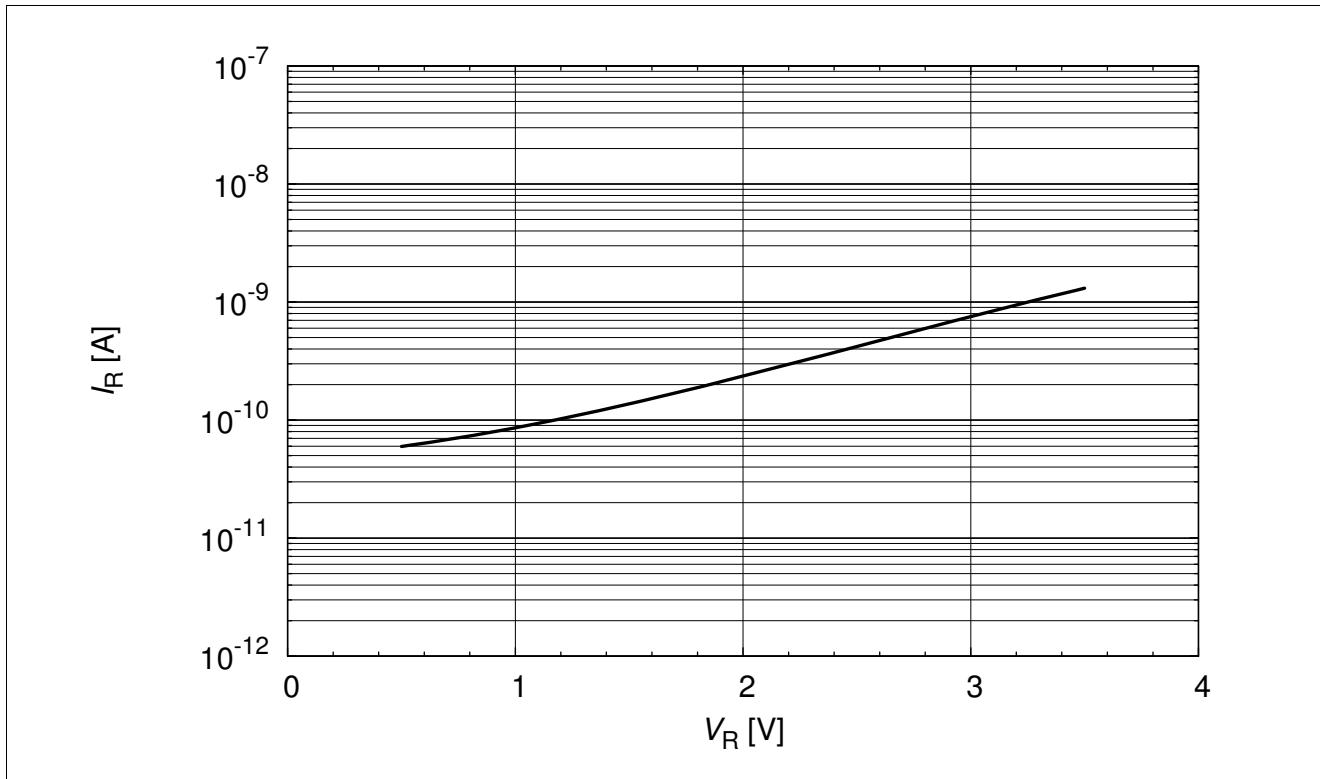


Figure 3 Reverse leakage current,  $I_R = (V_R)$

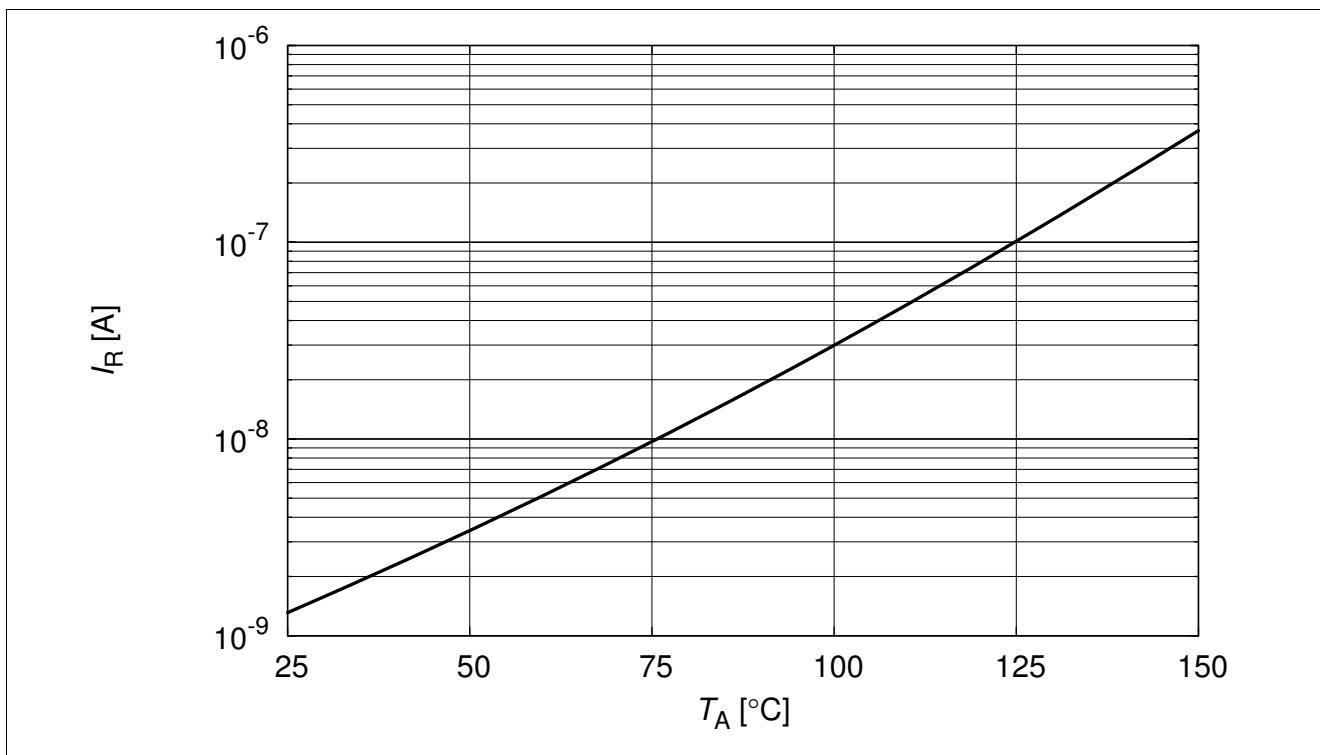


Figure 4 Reverse current  $I_R = f(T_A)$ ,  $V_R = 3.3$  V

Typical Characteristics at  $T_A=25^\circ\text{C}$ , unless otherwise specified

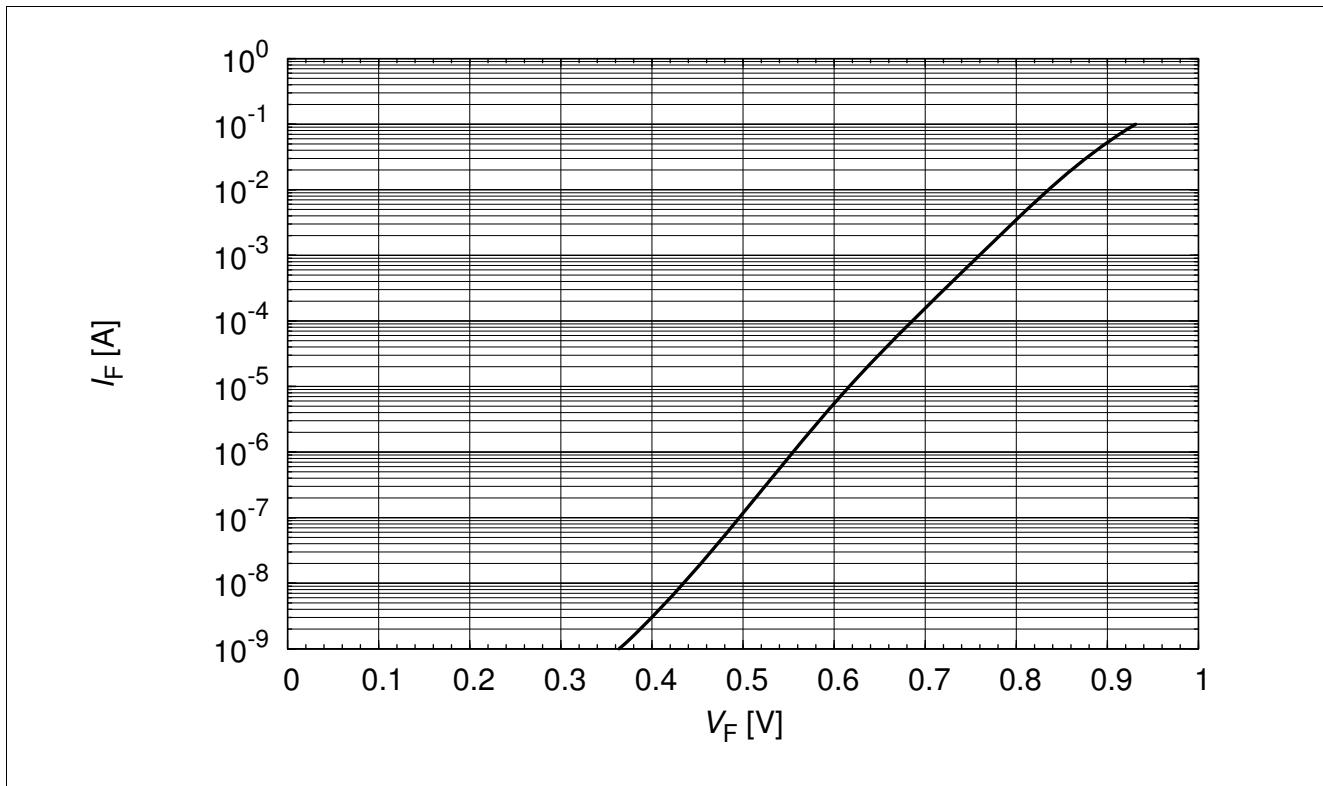


Figure 5 Forward current,  $I_F = (V_F)$

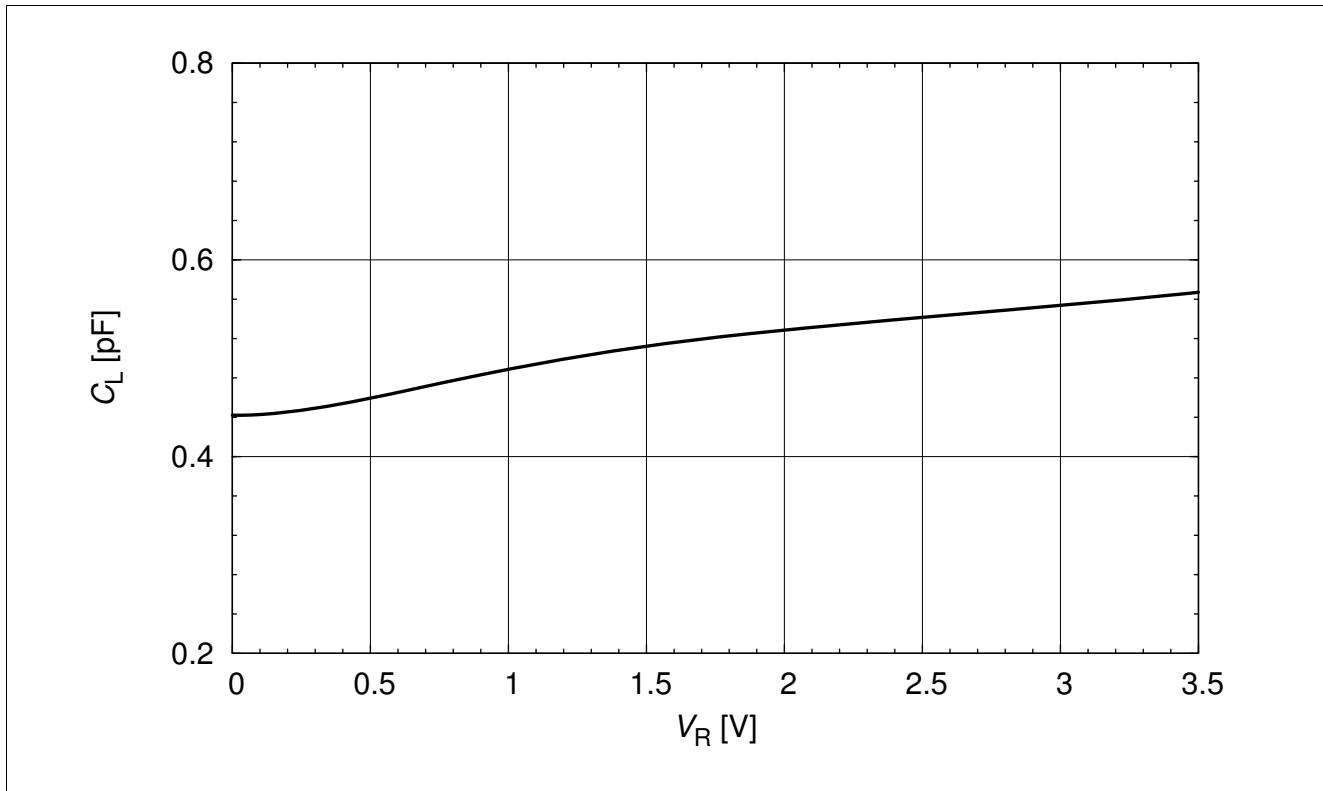


Figure 6 Line capacitance  $C_L = f(V_R), f = 1\text{MHz}$ , from pin 1 to pin 2

Typical Characteristics at  $T_A=25^\circ\text{C}$ , unless otherwise specified

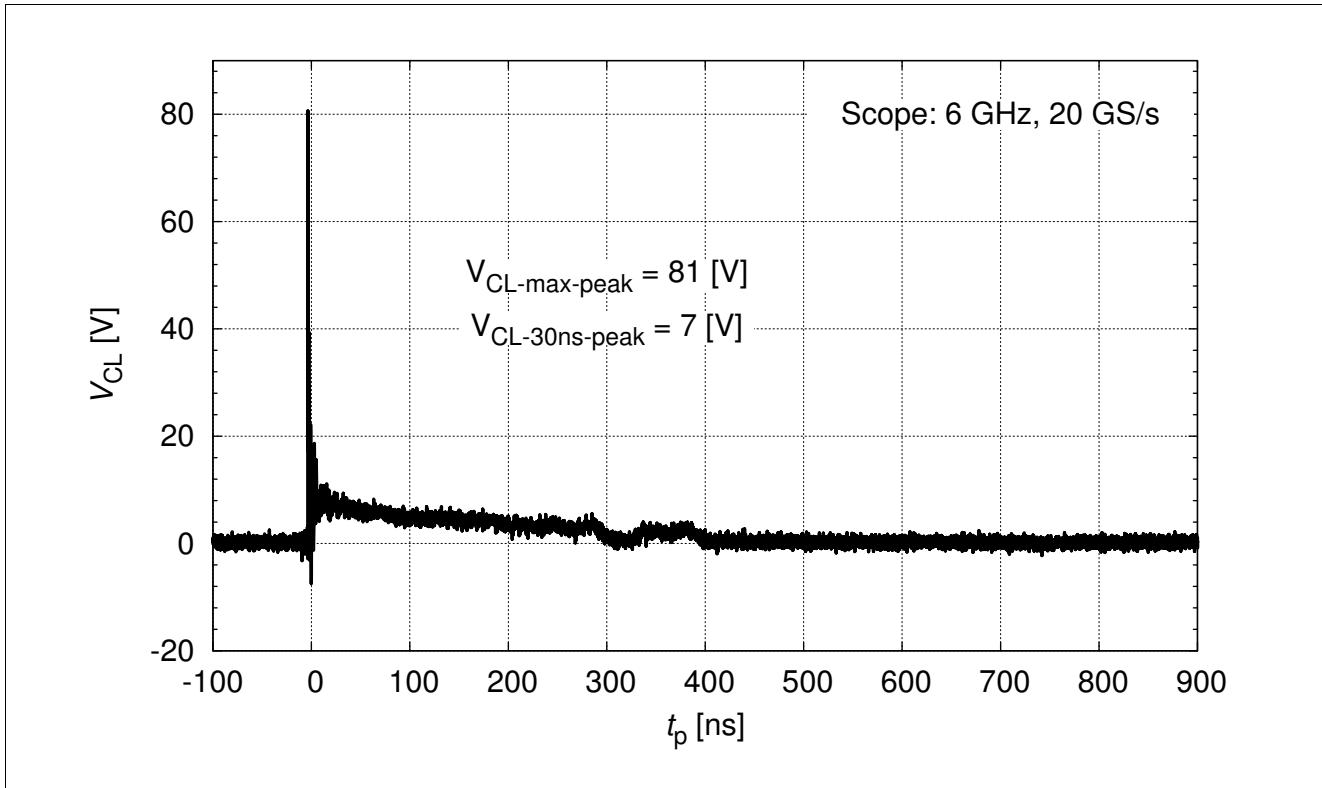


Figure 7 Clamping voltage (ESD):  $V_{CL} = f(t)$ , 8 kV positive pulse from pin 1 to pin 2

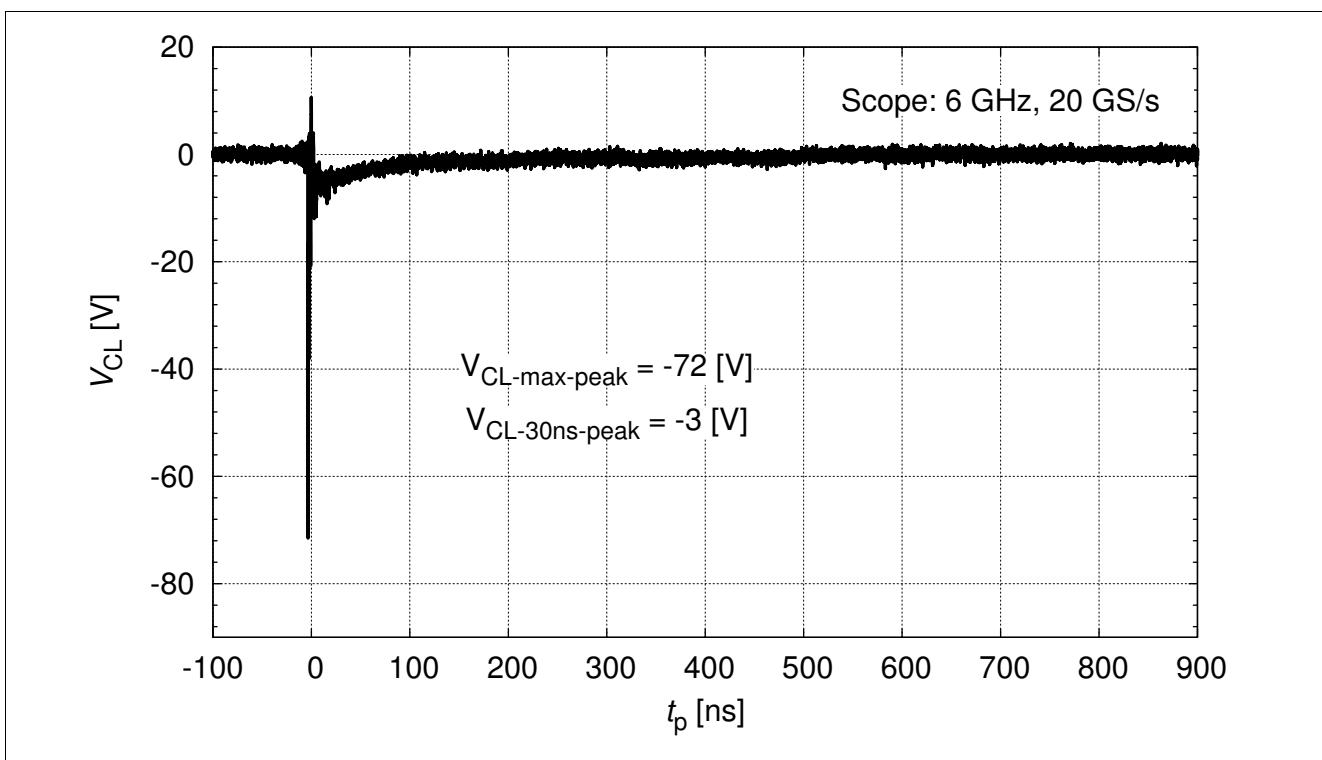


Figure 8 Clamping voltage (ESD):  $V_{CL} = f(t)$ , 8 kV negative pulse from pin 1 to pin 2

Typical Characteristics at  $T_A=25^\circ\text{C}$ , unless otherwise specified

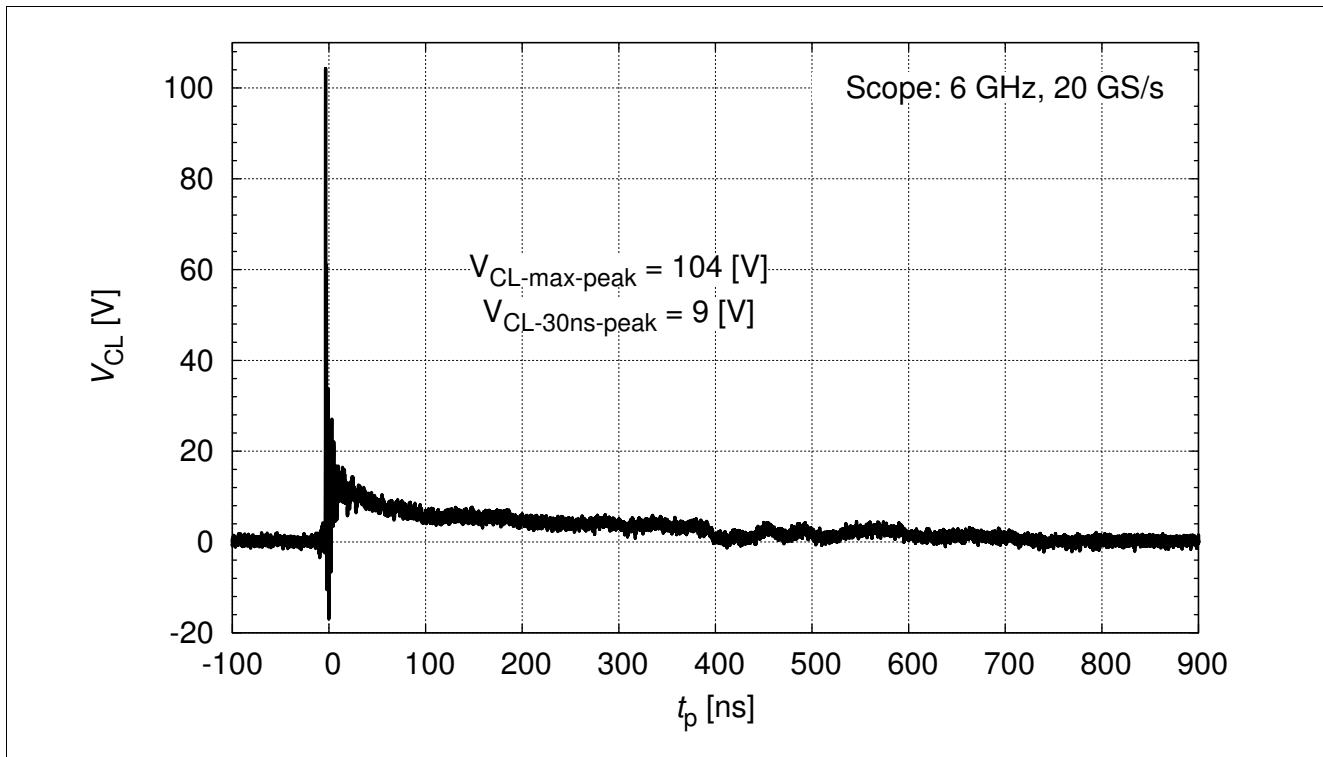


Figure 9 Clamping voltage (ESD):  $V_{CL} = f(t)$ , 15 kV positive pulse from pin 1 to pin 2

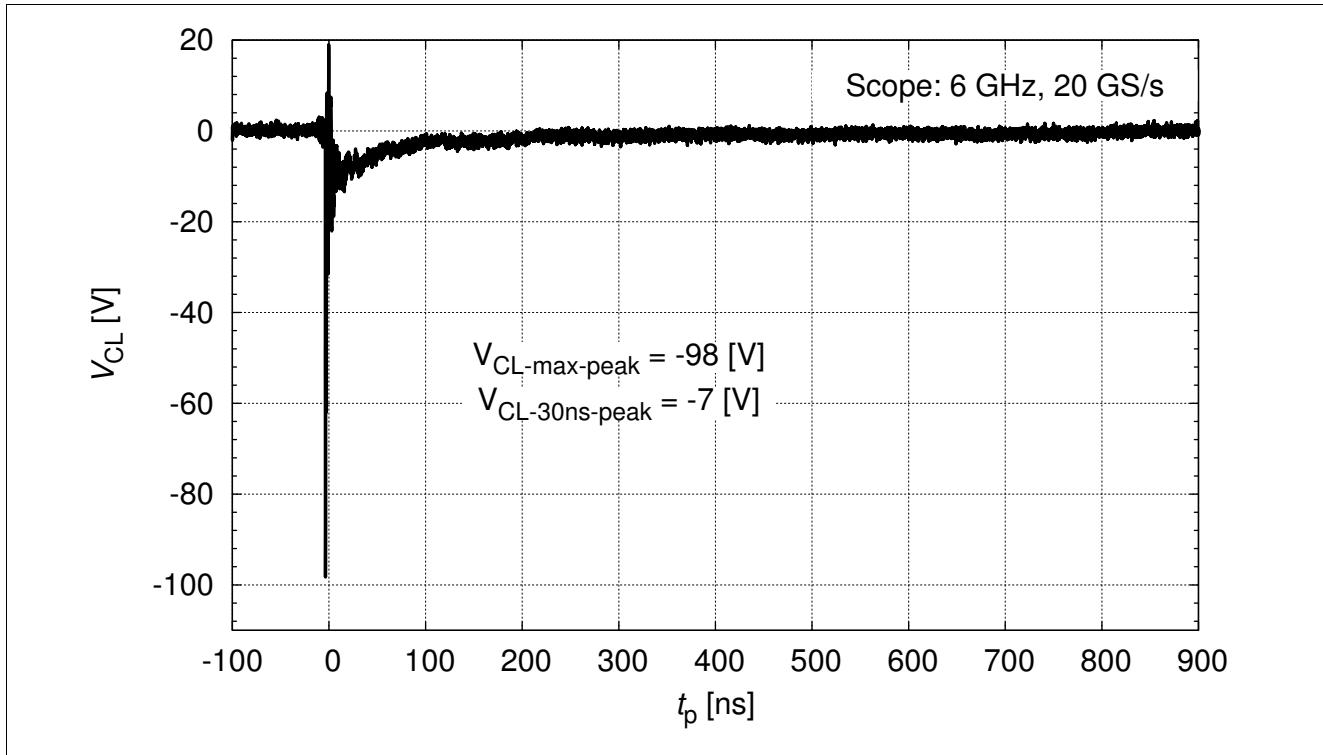
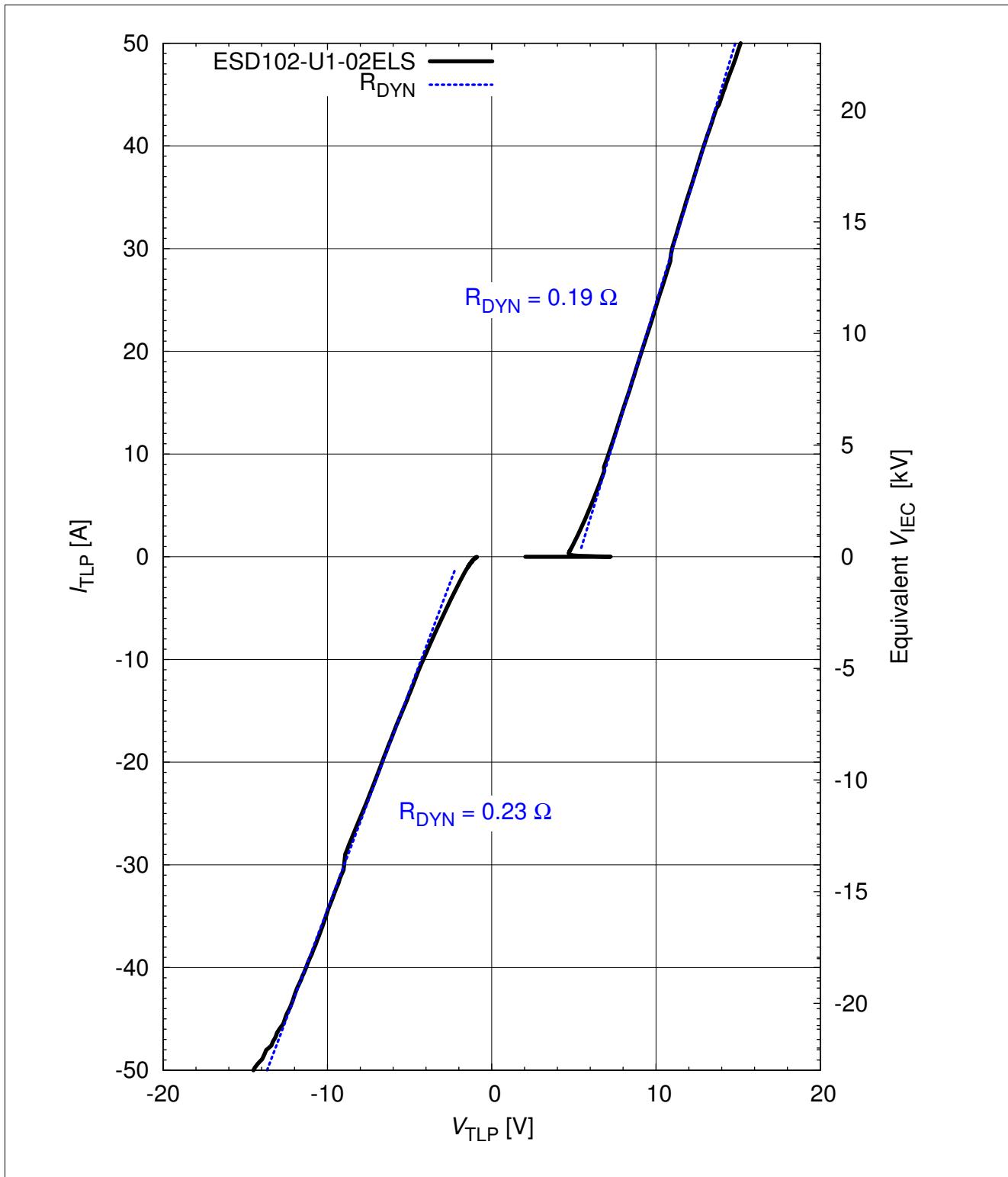


Figure 10 Clamping voltage (ESD):  $V_{CL} = f(t)$ , 15 kV negative pulse from pin 1 to pin 2

Typical Characteristics at  $T_A=25^\circ\text{C}$ , unless otherwise specified

 Figure 11 Clamping voltage (TLP):  $I_{\text{TLP}} = f(V_{\text{TLP}})$  [1], pin 1 to pin 2

Typical Characteristics at  $T_A=25^\circ\text{C}$ , unless otherwise specified

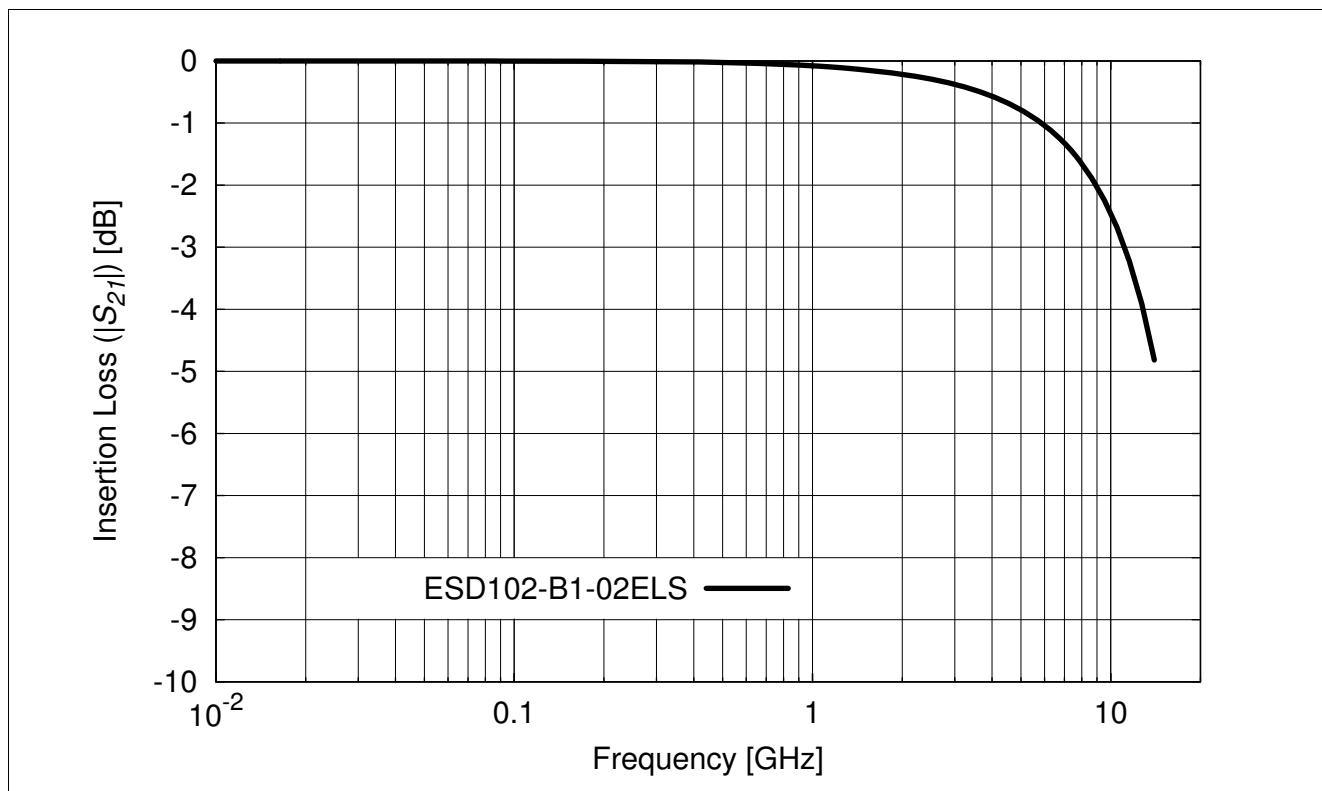


Figure 12 Insertion loss vs. frequency in a  $50\ \Omega$  system

## 5 Application Information

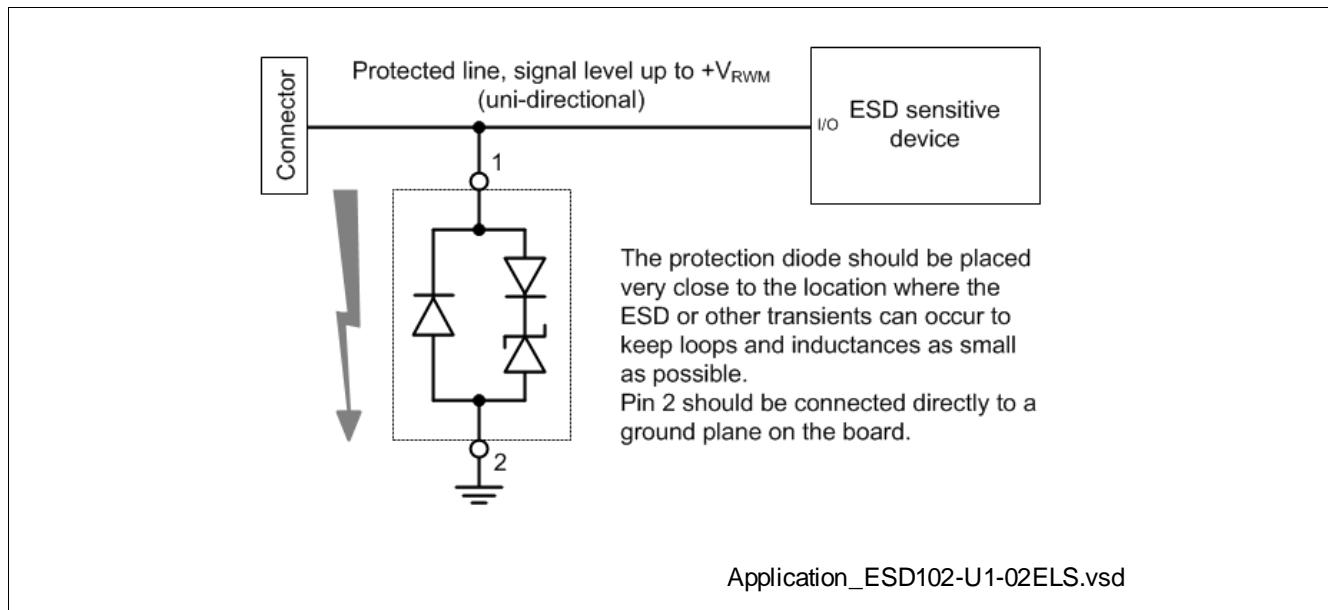
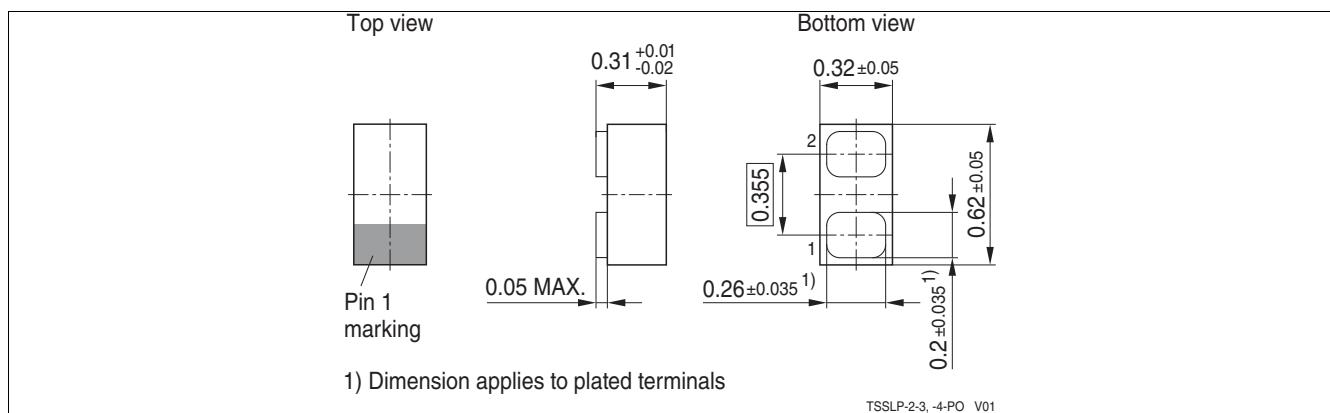


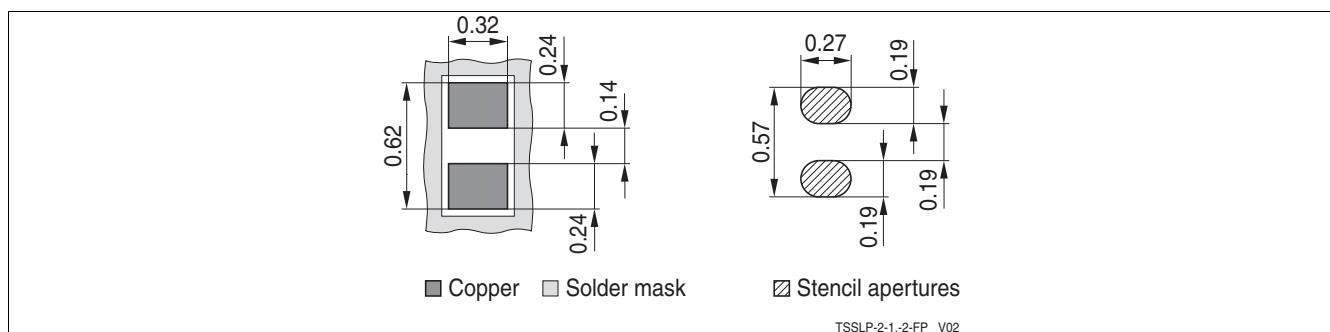
Figure 13 Single line, uni-directional ESD / Transient protection[2]

## 6 Package Information

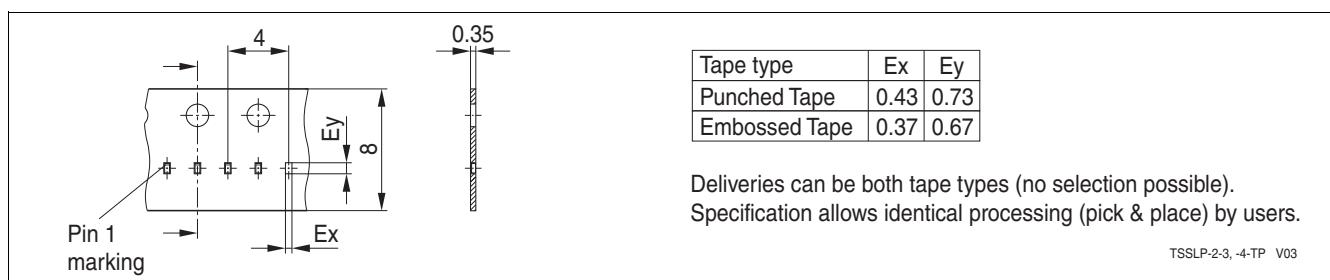
### 6.1 TSSLP-2-3



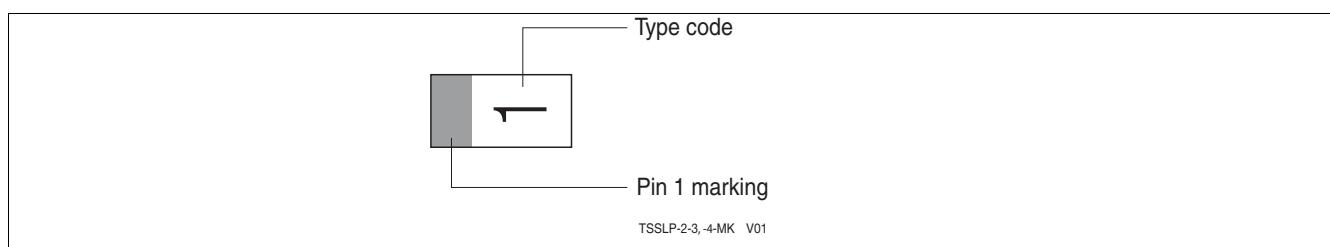
**Figure 14 TSSLP-2-3 Package outline (dimension in mm)**



**Figure 15 TSSLP-2-3 Footprint (dimension in mm)**



**Figure 16 TSSLP-2-3 Packing (dimension in mm)**



**Figure 17 TSSLP-2-3 Marking example** [Table 1 “Part Information” on Page 3](#)

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**References****References**

- [1] On-chip ESD protection for integrated circuits, Albert Z. H. Wang, ISBN:0-7923-7647-1
- [2] Infineon AG - **Application Note AN210:** Effective ESD Protection Design at System Level Using VF-TLP Characterization Methodology
- [3] Infineon AG - Recommendations for PCB Assembly of Infineon TSLP and TSSLP Package

**Revision History: Revision 1.1, 2014-02-13**

Page or Item	Subjects (major changes since previous revision)
<b>Revision 1.2, 2015-12-14</b>	
All	Layout change

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